

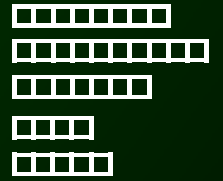
Session 8: Solid State Devices

# Recombination-Generation



# Outline

1. I
- 2.
- 3.
- 4.
- 5.



- ⊙ A
  - B
  - C
  - D
  - E
- ⊙ F
  - G
- ⊙ H
- ⊙ I
- ⊙ J








# Outline

1. I	□□□□□□□□
2.	□□□□□□□□□□
3.	□□□□□□□
4.	□□□□
5.	□□□□

● Ref: ?



# Non-Equilibrium Process

1. I 
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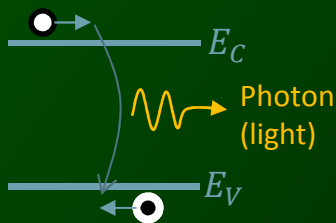
Whenever the thermal-equilibrium condition of a semiconductor system is disturbed  $pn \neq n_i^2$  processes exist to restore the system to equilibrium

Generation and recombination processes act to change the carrier concentrations, and thereby indirectly affect current flow

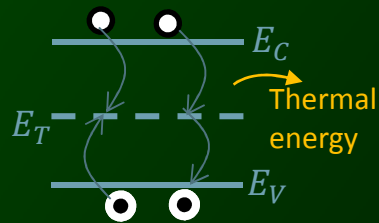
Recombination mechanisms:  $pn > n_i^2$

Generation mechanisms:  $pn < n_i^2$

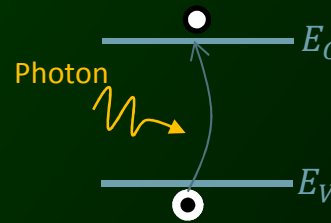
Direct



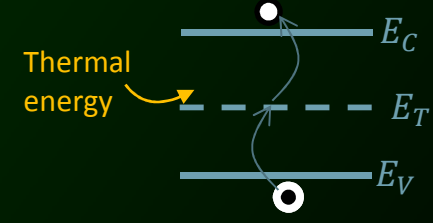
R-G Center



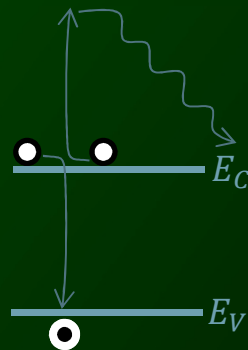
Band-to-band



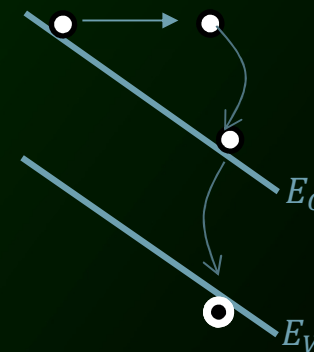
R-G Center



Auger



Impact Ionization

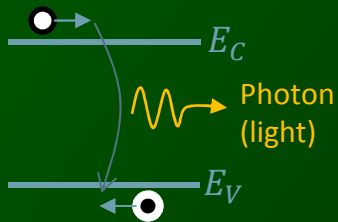
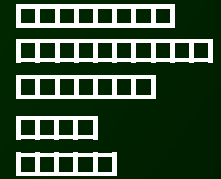


Recombination in Si is primarily via R-G centers



# Recombination Mechanisms

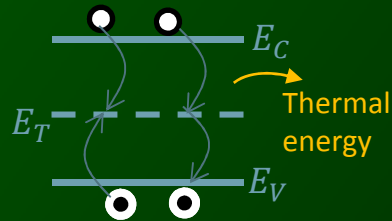
1. |
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Direct or Band to Band:

Basis for light emission devices

Photon (single particle of light) or multiple phonons (single quantum of lattice vibration – equivalent to saying thermal energy)

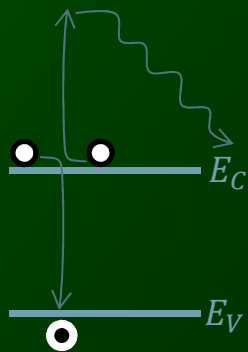


R-G Center:

Also known as Shockley-Read-Hall (SRH) recombination

Photon (single particle of light) or multiple phonons (single quantum of lattice vibration – equivalent to saying thermal energy)

Note: Trap level, Two steps: 1st Carrier is trapped at a defect/impurity, 2nd Carrier (opposite type) is attracted to the RG center and annihilates the 1st carrier



Auger:

Requires 3 particles, Two steps:

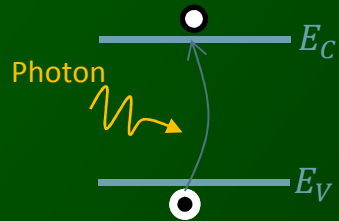
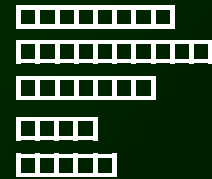
1st carrier and 2nd carrier of the same type collide instantly annihilating the electron hole pair (1st and 3rd carrier).

The energy lost in the annihilation process is given to the 2nd carrier. 2nd carrier gives off a series of phonons until its energy returns to equilibrium energy ( $E \sim E_c$ )



# Generation Mechanisms

1. |
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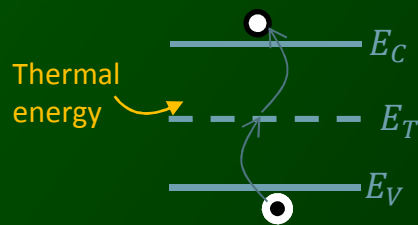


Direct or Band to Band:

Does not have to be a direct bandgap material

Mechanism that results in  $n_i$

Basis for light absorption devices such as semiconductor photodetectors, solar cells, etc.



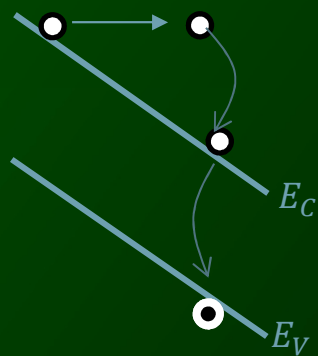
R-G Center:

Two steps:

A bonding electron is trapped at an unintentional defect/impurity generating a hole in the valence band

This trapped electron is then promoted to the conduction band resulting in a new electron-hole pair

Almost always detrimental to electronic devices



Impact Ionization:

Requires 3 particles and typically high electric fields

1st carrier is accelerated by high electric fields

Collides with a lattice atom

Knocks out a bonding electron

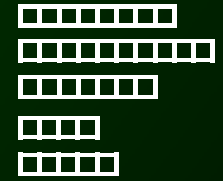
Creates an electron hole pair

What is it called when this process repeats and what device is it useful for?



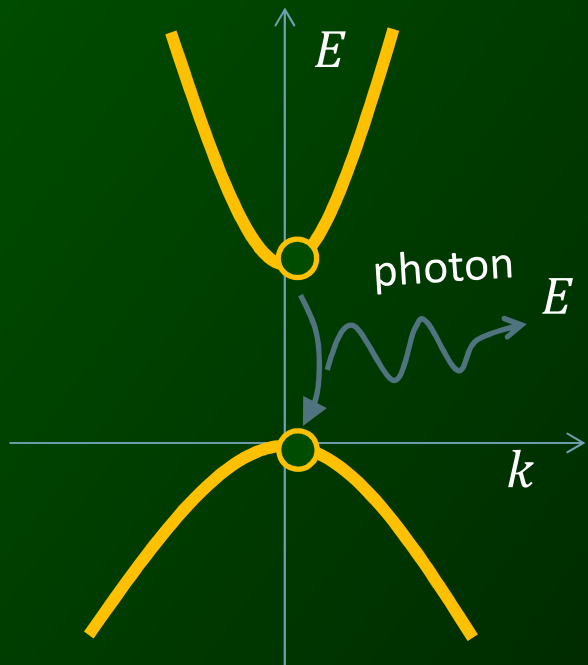
# Photon/Phonon Energy and Wavevector

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Direct Materials

GaAs



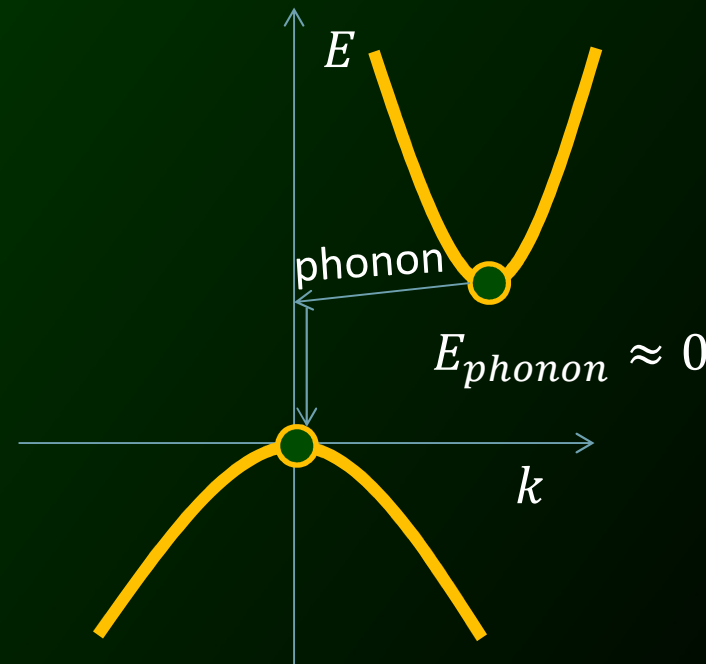
$$E = h\nu = E_C - E_V$$

$$\hbar k_{\text{photon}} \approx 0$$

Applications: LEDs, Lasers

Indirect Materials

Si, Ge



# Net Rate of Recombination-Generation

1.	□□□□□□□□
2.	□□□□□□□□□□
3.	□□□□□□□□
4.	□□□□
5.	□□□□

SRH recom-gen:

$$R = \frac{np - n_i^2}{\tau_p(n + n_1) + \tau_n(p + p_1)}$$

$$\tau_n = \frac{1}{c_p N_T}$$
$$\tau_p = \frac{1}{c_n N_T}$$

$$n_1 p_1 = n_i^2$$

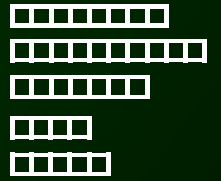
$$n_1 = n_i g_D e^{\beta(E_T - E_i)}$$

$$p_1 = n_i g_D^{-1} e^{\beta(E_i - E_T)}$$





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$$E_G(Al_xGa_{1-x}As) = 1.24(GaAs) + 1.247x$$

$$\Delta E_c = \Delta E_G$$

